Se	Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination
10/695,061	KIM ET AL.
Examiner	Art Unit
Matthew Landau	2815

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Class	Subclass	Date	Examiner		
257	377,382 E21.587, 793,774 586	2/20/06	M		
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257	773 774 377, 382,	3/20/08	m
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438	58-6		17
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